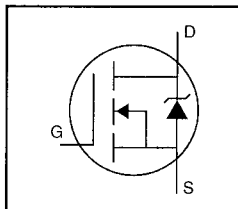


## HEXFET® Power MOSFET

- Dynamic  $dv/dt$  Rating
- Logic-Level Gate Drive
- $R_{DS(on)}$  Specified at  $V_{GS}=4V$  &  $5V$
- $175^{\circ}C$  Operating Temperature
- Fast Switching
- Ease of Paralleling
- Simple Drive Requirements



$$V_{DSS} = 60V$$

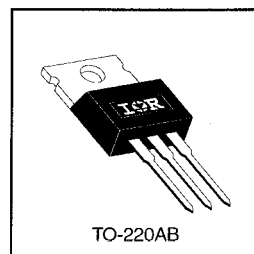
$$R_{DS(on)} = 0.028\Omega$$

$$I_D = 50^*A$$

### Description

Third Generation HEXFETs from International Rectifier provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 watts. The low thermal resistance and low package cost of the TO-220 contribute to its wide acceptance throughout the industry.



DATA SHEETS

### Absolute Maximum Ratings

	Parameter	Max.	Units
$I_D$ @ $T_C = 25^{\circ}C$	Continuous Drain Current, $V_{GS}$ @ 5.0 V	50*	A
$I_D$ @ $T_C = 100^{\circ}C$	Continuous Drain Current, $V_{GS}$ @ 5.0 V	36	
$I_{DM}$	Pulsed Drain Current ①	200	
$P_D$ @ $T_C = 25^{\circ}C$	Power Dissipation	150	W
	Linear Derating Factor	1.0	W/ $^{\circ}C$
$V_{GS}$	Gate-to-Source Voltage	$\pm 10$	V
$E_{AS}$	Single Pulse Avalanche Energy ②	400	mJ
$dv/dt$	Peak Diode Recovery $dv/dt$ ③	4.5	V/ns
$T_J$	Operating Junction and Storage Temperature Range	-55 to +175	$^{\circ}C$
$T_{STG}$	Soldering Temperature, for 10 seconds	300 (1.6mm from case)	
	Mounting Torque, 6-32 or M3 screw	10 lbf•in (1.1 N•m)	

### Thermal Resistance

	Parameter	Min.	Typ.	Max.	Units
$R_{\theta JC}$	Junction-to-Case	—	—	1.0	$^{\circ}C/W$
$R_{\theta CS}$	Case-to-Sink, Flat, Greased Surface	—	0.50	—	
$R_{\theta JA}$	Junction-to-Ambient	—	—	62	

## Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Test Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	60	—	—	V	$V_{GS}=0\text{V}$ , $I_D=250\mu\text{A}$
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient	—	0.070	—	$\text{V}/^\circ\text{C}$	Reference to $25^\circ\text{C}$ , $I_D=1\text{mA}$
$R_{DS(on)}$	Static Drain-to-Source On-Resistance	—	—	0.028	$\Omega$	$V_{GS}=5.0\text{V}$ , $I_D=31\text{A}$ ④
		—	—	0.039		$V_{GS}=4.0\text{V}$ , $I_D=25\text{A}$ ④
$V_{GS(th)}$	Gate Threshold Voltage	1.0	—	2.0	V	$V_{DS}=V_{GS}$ , $I_D=250\mu\text{A}$
$g_{fs}$	Forward Transconductance	23	—	—	S	$V_{DS}=25\text{V}$ , $I_D=31\text{A}$ ④
$I_{DSS}$	Drain-to-Source Leakage Current	—	—	25	$\mu\text{A}$	$V_{DS}=60\text{V}$ , $V_{GS}=0\text{V}$
		—	—	250		$V_{DS}=48\text{V}$ , $V_{GS}=0\text{V}$ , $T_J=150^\circ\text{C}$
$I_{GSS}$	Gate-to-Source Forward Leakage	—	—	100	nA	$V_{GS}=10\text{V}$
	Gate-to-Source Reverse Leakage	—	—	-100		$V_{GS}=-10\text{V}$
$Q_g$	Total Gate Charge	—	—	66	nC	$I_D=51\text{A}$
$Q_{gs}$	Gate-to-Source Charge	—	—	12		$V_{DS}=48\text{V}$
$Q_{gd}$	Gate-to-Drain ("Miller") Charge	—	—	43		$V_{GS}=5.0\text{V}$ See Fig. 6 and 13 ④
$t_{d(on)}$	Turn-On Delay Time	—	17	—	ns	$V_{DD}=30\text{V}$
$t_r$	Rise Time	—	230	—		$I_D=51\text{A}$
$t_{d(off)}$	Turn-Off Delay Time	—	42	—		$R_G=4.6\Omega$
$t_f$	Fall Time	—	110	—		$R_D=0.56\Omega$ See Figure 10 ④
$L_D$	Internal Drain Inductance	—	4.5	—	nH	Between lead, 6 mm (0.25in.) from package and center of die contact
$L_S$	Internal Source Inductance	—	7.5	—		
$C_{iss}$	Input Capacitance	—	3300	—	pF	$V_{GS}=0\text{V}$
$C_{oss}$	Output Capacitance	—	1200	—		$V_{DS}=25\text{V}$
$C_{rss}$	Reverse Transfer Capacitance	—	200	—		$f=1.0\text{MHz}$ See Figure 5



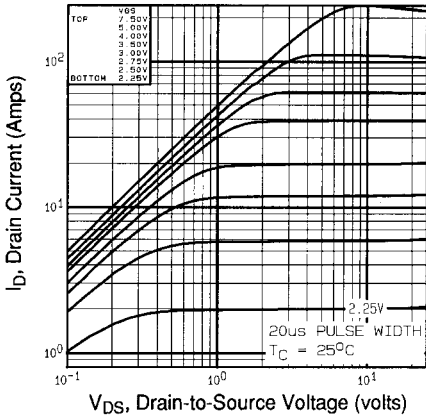
## Source-Drain Ratings and Characteristics

	Parameter	Min.	Typ.	Max.	Units	Test Conditions
$I_S$	Continuous Source Current (Body Diode)	—	—	50*	A	MOSFET symbol showing the integral reverse p-n junction diode.
$I_{SM}$	Pulsed Source Current (Body Diode) ①	—	—	200		
$V_{SD}$	Diode Forward Voltage	—	—	2.5	V	$T_J=25^\circ\text{C}$ , $I_S=51\text{A}$ , $V_{GS}=0\text{V}$ ④
$t_{rr}$	Reverse Recovery Time	—	130	180	ns	$T_J=25^\circ\text{C}$ , $I_F=51\text{A}$
$Q_{rr}$	Reverse Recovery Charge	—	0.84	1.3	$\mu\text{C}$	$di/dt=100\text{A}/\mu\text{s}$ ④
$t_{on}$	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by $L_S+L_D$ )				

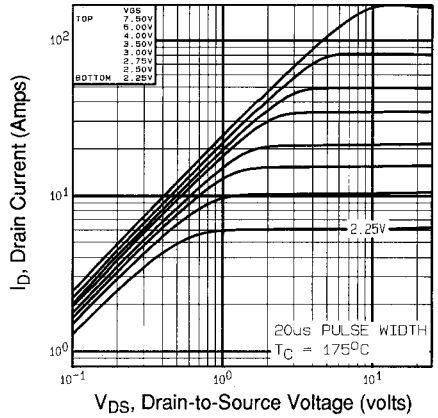
Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature (See Figure 11)
- ②  $V_{DD}=25\text{V}$ , starting  $T_J=25^\circ\text{C}$ ,  $L=179\mu\text{H}$ ,  $R_G=25\Omega$ ,  $I_{AS}=51\text{A}$  (See Figure 12)
- ③  $I_{SD}\leq 51\text{A}$ ,  $di/dt\leq 250\text{A}/\mu\text{s}$ ,  $V_{DD}\leq V_{(BR)DSS}$ ,  $T_J\leq 175^\circ\text{C}$
- ④ Pulse width  $\leq 300\mu\text{s}$ ; duty cycle  $\leq 2\%$ .

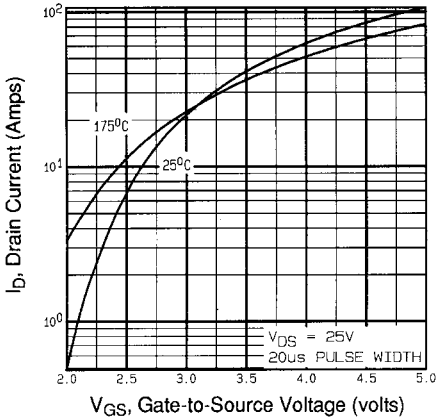
\* Current limited by the package, (Die Current =51A)



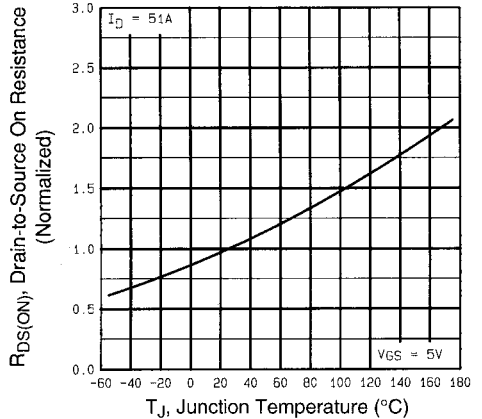
**Fig 1.** Typical Output Characteristics,  
 $T_C=25^\circ\text{C}$



**Fig 2.** Typical Output Characteristics,  
 $T_C=175^\circ\text{C}$

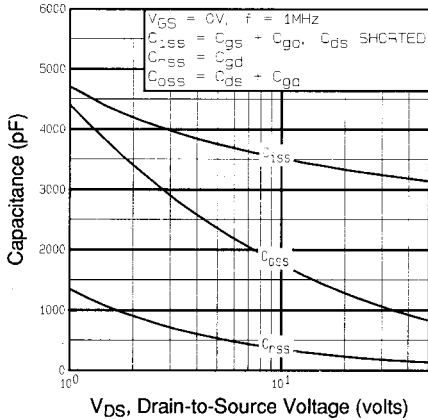


**Fig 3.** Typical Transfer Characteristics

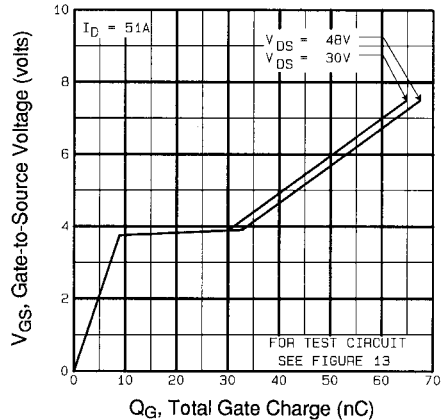


**Fig 4.** Normalized On-Resistance  
Vs. Temperature

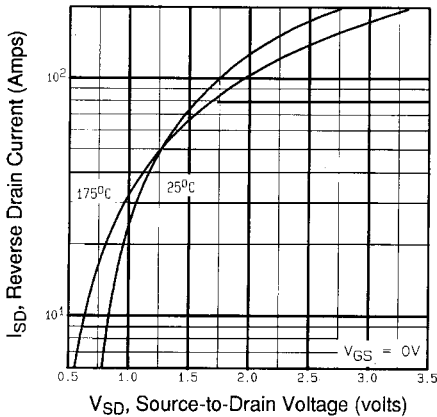
DATA SHEETS



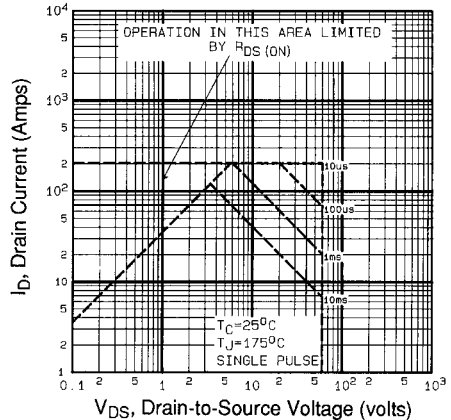
**Fig 5.** Typical Capacitance Vs. Drain-to-Source Voltage



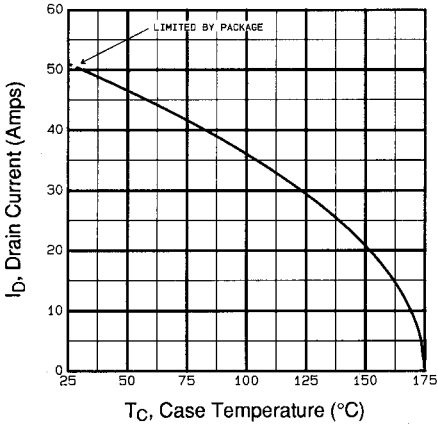
**Fig 6.** Typical Gate Charge Vs. Gate-to-Source Voltage



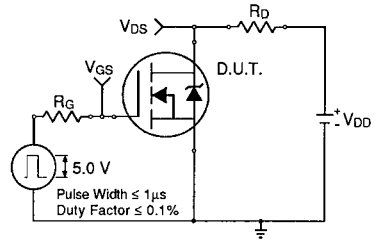
**Fig 7.** Typical Source-Drain Diode Forward Voltage



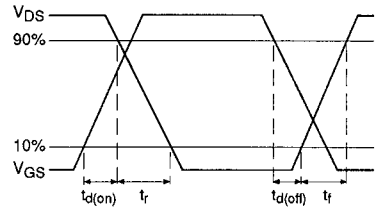
**Fig 8.** Maximum Safe Operating Area



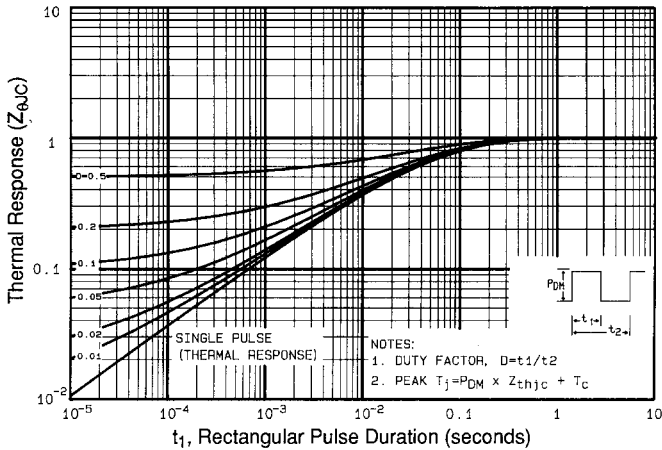
**Fig 9.** Maximum Drain Current Vs. Case Temperature



**Fig 10a.** Switching Time Test Circuit

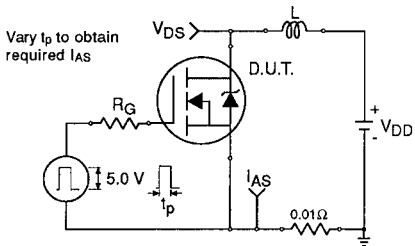


**Fig 10b.** Switching Time Waveforms

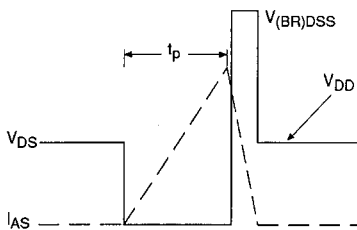


**Fig 11.** Maximum Effective Transient Thermal Impedance, Junction-to-Case

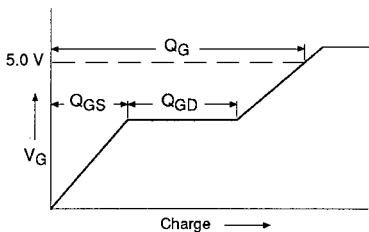
DATA SHEETS



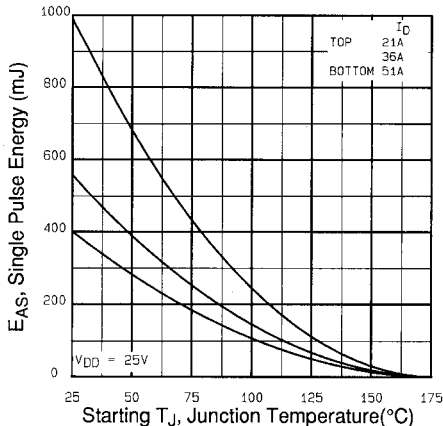
**Fig 12a.** Unclamped Inductive Test Circuit



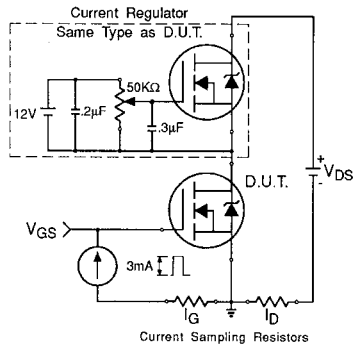
**Fig 12b.** Unclamped Inductive Waveforms



**Fig 13a.** Basic Gate Charge Waveform



**Fig 12c.** Maximum Avalanche Energy Vs. Drain Current



**Fig 13b.** Gate Charge Test Circuit

**Appendix A:** Figure 14, Peak Diode Recovery  $dv/dt$  Test Circuit – See page 1505

**Appendix B:** Package Outline Mechanical Drawing – See page 1509

**Appendix C:** Part Marking Information – See page 1516

**Appendix E:** Optional Leadforms – See page 1525



LittleDiode supplies new, hard to find or obsolete electronic components and semiconductors all over the world.

With over two million different components listed you are sure to find the part you need.

Feel free to visit us today at our online store:

[LittleDiode.com](http://LittleDiode.com)

Looking forward to providing you with the best possible service.